TRADE FORM 1449 (Modified)

Atty Docket No. UNTYP027

Application No.:

Information Disclosure

Applicant:

10/665,882

Statement By Applicant

RINERSON et al. Filing Date

Group

(Use Several Sheets if Necessary)

September 19, 2003

2811

U.S. Patent Documents

Examiner						Sub-	Filing
Initial	No.	Patent No.	Date	Patentee	Class	class	Date
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Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or	Ţ	Sub-	Trans	lation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
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Other Documents

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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.